


<b>Search Notes</b>  	<b>Application/Control No.</b>  10509867	<b>Applicant(s)/Patent Under Reexamination</b>  TAKANO ET AL.
	<b>Examiner</b>  CHRISTOPHER M BRANDT	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
370	331	12/17/2007	CMB
455	442, 436, 522, 466	12/17/2007	CMB

SEARCH NOTES		
Search Notes	Date	Examiner
(EASTImage and Keyword Search in USPAT, US-PGPUB, DERWENT, EPO, JPO, IBM_TDB (See Attached Search Strategy))	12/17/2008	CMB
Updated Search	10/06/2008	CMB
Updated Search	05/12/2009	CMB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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